

Notice of References Cited	Application/Control No. 09/939,824	Applicant(s)/Patent Under Reexamination FUKUDA ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,027,025	06-1991	Saneshige et al.	310/156.38
	B	US-			
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	D	US-			
	E	US-			
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	I	US-			
	J	US-			
	K	US-			
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	M	US-			

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	U	
	V	
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